

# Large Sample Property of General Shock Model

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KEY WORDS: general shock model;censoring data;Kaplan-Meier estimator

MATHEMATICAL SUBJECT CLASSIFICATION: 11K06

## Abstract:

In this paper, we mainly study the statistical inference of the general shock model. Let  $N = \min\{X_i \geq z\}$  be the shock times until the system fails.  $z$  is the threshold level, a non-negative constant. Obviously,  $T = \sum_{k=1}^N Y_k$  be the lifetime of the system. If the system is censored by a random variable  $U$ :  $T_1 = U \wedge T$ ,  $T_1$  is the lifetime of the system under the stochastic censoring data conditions. In section 2.1, we get the expression of  $z = \bar{F}^{-1}(\frac{EY}{ET})$  Wald equation, and use sample distribution function, get the estimation of  $\bar{F}^{-1}$ .  $Y_i$  and  $T$  are censored by  $U$ , we use Kaplan-Meier method to estimate  $ET$ , then get the survival function of  $T$  and the estimation of mean lifetime  $ET$ ,

$$\hat{ET} = \int_0^{\infty} \hat{S}^n(t) dt, \quad \hat{S}^n(t) = \prod_{s \leq t} (1 - \Delta \hat{A}(s)) = \prod_{s \leq t} \left(1 - \frac{\Delta N(s)}{Y(s)}\right)$$

$EY$  can be calculated by its distribution. so  $\hat{ET} \xrightarrow{P} ET$ , and  $\frac{EY}{\hat{ET}} \xrightarrow{P} \frac{EY}{ET}$ , then we get:  $\hat{z} \xrightarrow{P} z$ . At last, we give the simulations of  $ET$  and  $z$ .